TOSHIBA Multi-Chip Device Silicon P Channel MOS Type (U-MOS III) / Schottky Barrier Diode

TPCF8B01

Notebook PC Applications Portable Equipment Applications

- Low drain-source ON resistance: RDS (ON) = 72 m Ω (typ.)
- High forward transfer admittance: $|Y_{fs}| = 4.7 \text{ S (typ.)}$
- Low leakage current: $I_{DSS} = -10 \, \mu A \, (max) \, (V_{DS} = -20 \, V)$
- Enhancement-model: $V_{th} = -0.5 \text{ to} -1.2 \text{ V}(V_{DS} = -10 \text{ V}, I_D = -200 \mu\text{A})$
- Low forward voltage: $V_{FM(2)} = 0.46V(typ.)$

Absolute Maximum Ratings

 $MOSFET (Ta = 25^{\circ}C)$

Characteristics			Symbol	Rating	Unit
Drain-source voltage			V_{DSS}	-20	V
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)			V_{DGR}	-20	V
Gate-source voltage			V_{GSS}	±8	V
Drain current	DC	(Note 1)	ID	-2.7	Α
	Pulse	(Note 1)	I_{DP}	-10.8	^
Single pulse avalar	Single pulse avalanche energy (Note 4)			1.2	mJ
Avalanche current			I _{AR}	-1.35	Α
Repetitive avalanche energy Single-device value at dual operation (Note 2a, 3b, 5)			E _{AR}	0.11	mJ

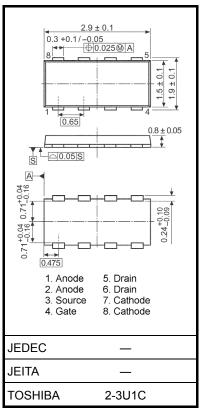
SBD ($Ta = 25^{\circ}C$)

Characteristics	Symbol	Rating	Unit
Repetitive peak reverse voltage	V_{RRM}	20	V
Average forward current (Note 2a, 6)	I _{F(AV)}	1.0	Α
Peak one cycle surge forward current (non-repetitive)	I _{FSM}	7(50Hz)	Α

Absolute Maximum Ratings for MOSFET and SBD (Ta = 25°C)

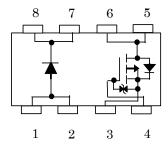
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Cha	Symbol	Rating	Unit						
Drain power dissipation (t = 5 s) (Note 2a)	Single-device operation (Note 3a) PD (1)		1.35						
	Single-device value at dual operation (Note 3b)	P _{D (2)}	1.12	W					
Drain power dissipation (t = 5 s) (Note 2b)	Single-device operation (Note 3a)	P _{D (1)}	0.53	VV					
	Single-device value at dual operation (Note 3b)	P _{D (2)}	0.33						
Channel temperature		T _{ch}	150	°C					
Storage temperature range		T _{stg}	-55~150	°C					
	·								

Unit: mm



Weight: 0.011 g (typ.)

Circuit Configuration



Note: For (Note 1), (Note 2), (Note 3), (Note 4), (Note 5), (Note 6) and (Note 7), please refer to the next page.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

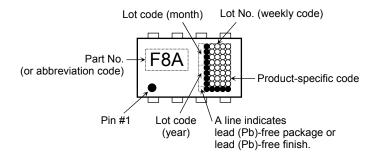
Thermal Characteristics for MOSFET and SBD

Charac	Symbol	Max	Unit		
Thermal resistance, channel to ambient (t = 5 s) (Note 2a)	Single-device operation (Note 3a) Rth (ch-		92.6	°C/W	
	Single-device value at dual operation (Note 3b)	R _{th (ch-a) (2)}	111.6	C/VV	
Thermal resistance, channel to ambient	Single-device operation (Note 3a)	R _{th (ch-a) (1)}	235.8	8 °C/W	
(t = 5 s) (Note 2b)	Single-device value at dual operation (Note 3b)	R _{th (ch-a) (2)}	378.8	0/44	

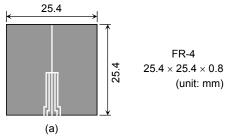
This transistor is an electrostatic sensitive device. Please handle with caution.

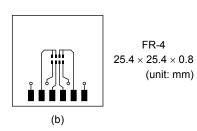
Schottky barrier diodes are having large-reverse-current-leakage characteristic compare to the other rectifier products. This current leakage and improper operating temperature or voltage may cause thermal runaway. Please take forward and reverse loss into consideration when you design.

Marking (Note 7)



- Note 1: Please use devices on condition that the channel temperature is below 150°C.
- Note 2: (a) Device mounted on a glass-epoxy board (b) Device mounted on a glass-epoxy board (b)





- Note 3: a) The power dissipation and thermal resistance values are shown for a single device (During single-device operation, power is only applied to one device.).
 - b) The power dissipation and thermal resistance values are shown for a single device (During dual operation, power is evenly applied to both devices.).
- Note 4: V_{DD} =-16 V, T_{ch} = 25°C (initial), L = 0.5 mH, R_G = 25 Ω , I_{AR} = -1.35 A
- Note 5: Repetitive rating; Pulse width limited by maximum channel temperature.
- Note 6: Rectangular waveform ($\alpha = 180^{\circ}$), V_R = 15V.
- Note 7: Black round marking "●" locates on the left lower side of parts number marking "F8A" indicates terminal No. 1.

Electrical Characteristics (Ta = 25°C)

MOSFET

Ch	aracteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	rrent	I _{GSS}	$V_{GS} = \pm 8 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μА
Drain cut-off curr	ent	I _{DSS}	V _{DS} = -20 V, V _{GS} = 0 V	_	_	-10	μА
Drain source bro	akdown voltago	V _{(BR) DSS}	$I_D = -10 \text{ mA}, V_{GS} = 0 \text{ V}$	-20	_	_	V
Drain-source breakdown voltage		V _{(BR) DSX}	$I_D = -10 \text{ mA}, V_{GS} = 8V$	-12	_	_	v
Gate threshold v	oltage	V _{th}	$V_{DS} = -10 \text{ V}, I_D = -200 \mu A$	-0.5	_	-1.2	V
		R _{DS} (ON)	V _{GS} = -1.8 V, I _D = -0.7 A	_	215	300	
Drain-source ON	resistance	R _{DS} (ON)	V _{GS} = -2.5 V, I _D = -1.4A	_	110	160	mΩ
		R _{DS} (ON)	V _{GS} = -4.5 V, I _D = -1.4 A	_	72	110	
Forward transfer admittance		Y _{fs}	V _{DS} = -10 V, I _D = -1.4 A	2.4	4.7	_	S
Input capacitance		C _{iss}	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz	_	470	_	pF
Reverse transfer capacitance		C _{rss}		_	70	_	
Output capacitance		C _{oss}		_	80	_	
	Rise time	t _r	VGS -5 V ID = -1.4 A	_	5	_	
Curitahin a tina	Turn-on time	t _{on}		_	9	_	
Switching time	Fall time	t _f		_	8	_	ns
	Turn-off time	t _{off}	$V_{DD} \simeq -10 \text{ V}$ Duty ≤ 1%, $t_W = 10 \text{ μs}$	_	26	_	
Total gate charge (gate-source plus gate-drain)		Qg	V _{DD} ≈ -16 V, V _{GS} = -5 V,	_	6	_	_
Gate-source cha	rge	Q _{gs}	$I_D = -2.7 \text{ A}$	_	4	_	nC
Gate-drain ("mille	er") charge	Q _{gd}]	_	2	_	

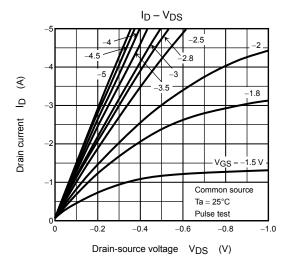
MOSFET Source-Drain Ratings and Characteristics

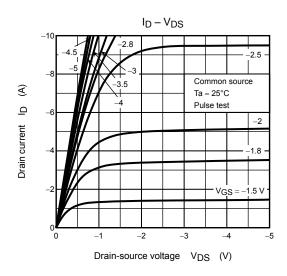
Characterist	ics	Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I _{DRP}	_	_	_	-10.8	Α
Forward voltage (diode)		V_{DSF}	$I_{DR} = -2.7 \text{ A}, V_{GS} = 0 \text{ V}$	_	_	-1.2	V

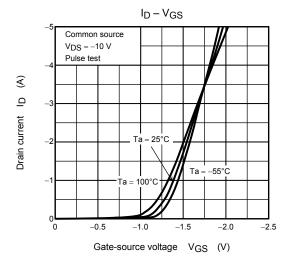
SBD

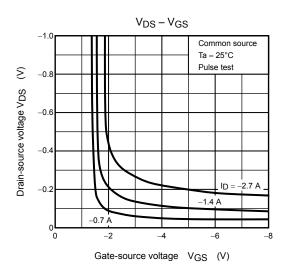
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Peak forward voltage	V _{FM(1)}	I _{FM} = 0.7 A	_	0.43	_	V
r eak lorward voltage	V _{FM(2)}	I _{FM} = 1.0 A	_	0.46	0.49	V
Repetitive peak reverse current	I _{RRM}	V _{RRM} = 20 V	_	_	50	μΑ
Junction capacitance	Cj	V _R = 10 V, f = 1 MHz		54	_	pF

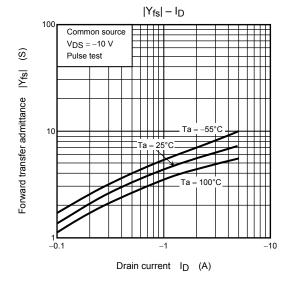
MOSFET

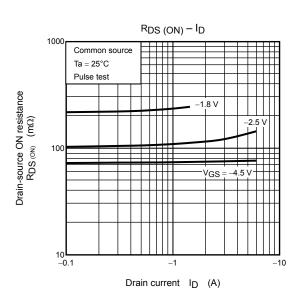


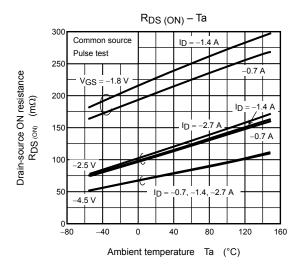


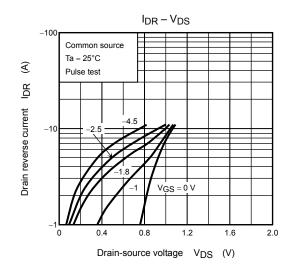


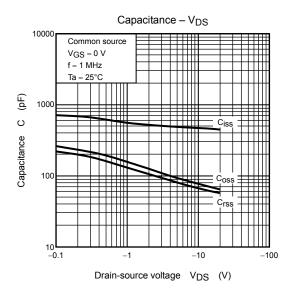


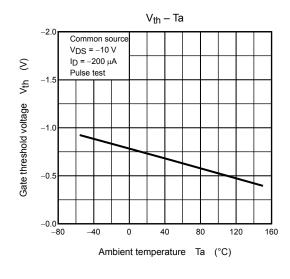


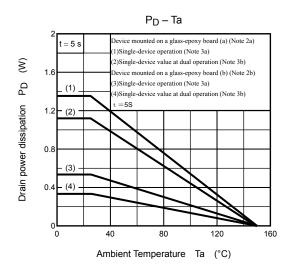


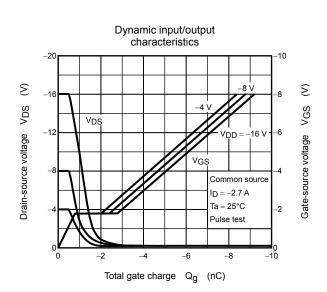


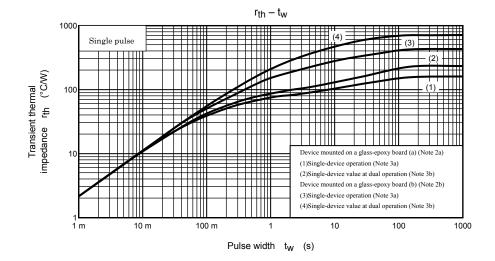


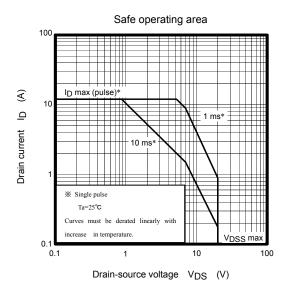






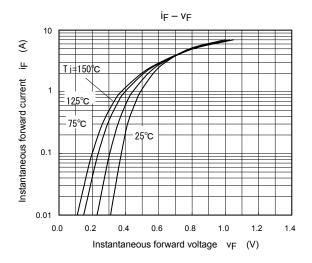


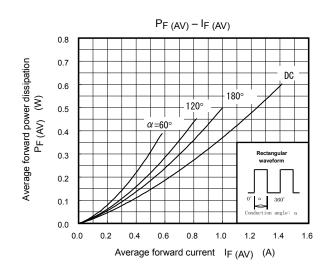


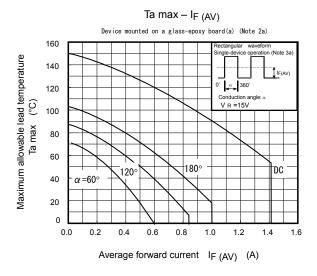


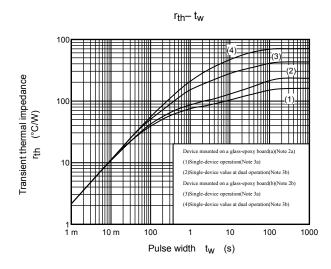
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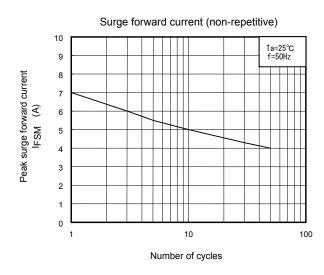
SBD

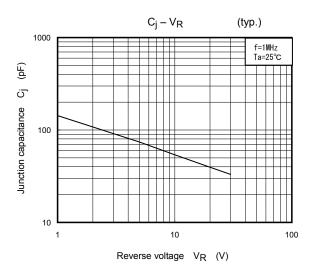


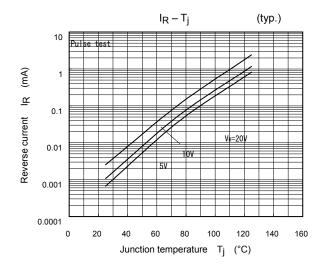


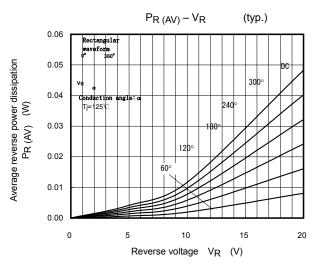












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